

Search Notes

Application/Control No.

10/808,794

Examiner

Nam Huynh

Applicant(s)/Patent under
Reexamination

LIOW ET AL.

Art Unit

2643

SEARCHED

Class	Subclass	Date	Examiner
455	556.1	12/21/2005	NTH
	556.2		
	164.2		
235	462.47	12/21/2005	NTH
	472.01		
	472.02		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
See EAST search notes.	12/21/2005	NTH